


<b>Search Notes</b>  	<b>Application/Control No.</b>  10618140	<b>Applicant(s)/Patent Under Reexamination</b>  CHIN, ALBERT K.
	<b>Examiner</b>  AMY T LANG	<b>Art Unit</b>  3731

SEARCHED			
Class	Subclass	Date	Examiner
606	129, 198, 41	5/4/09	ATL
600	37, 16-18, 674. 471	5/4/09	ATL
128	898	5/4/09	ATL
607	122, 101, 116	5/4/09	ATL

SEARCH NOTES		
Search Notes	Date	Examiner
STIC search report	11/15/07	ATL
Consulted with Examiner Chris Koharski	05/01/2009	ATL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
606	167, 41	5/4/09	ATL

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